Notic of Referenc s Cited Application/Control No. | Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL. | Examiner | Art Unit | Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6463418	10-2002	Todd	705/44
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	С	US-			
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NON-PATENT DOCUMENTS

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